TOSHIBA TRANSISTOR SILICON PNP EPITAXIAL TYPE (PCT PROCESS)

2 S A 1 2 4 1

POWER AMPLIFIER APPLICATIONS POWER SWITCHING APPLICATIONS

Low Collector Saturation Voltage

: $V_{\text{CE (sat)}} = -0.5 \text{ V (Max.)} (I_{\text{C}} = -1 \text{ A})$

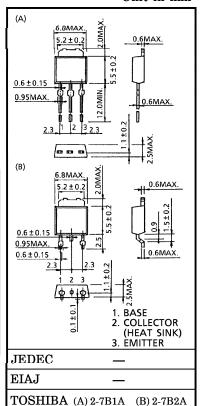
Excellent Switching Time : $t_{stg} = 1.0 \,\mu s$ (Typ.)

Complementary to 2SC3076

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	YMBOL RATING			
Collector-Base Voltage	v_{CBO}	-50	V		
Collector-Emitter Voltage	v_{CEO}	-50	V		
Emitter-Base Voltage	$V_{ m EBO}$	V _{EBO} -5			
Collector Current	$I_{\mathbf{C}}$	-2	Α		
Base Current		$I_{\mathbf{B}}$	-1	Α	
Collector Power Ta =	= 25°C	Da	1.0	w	
Dissipation Tc =	= 25°C	PC	10		
Junction Temperature		T_{j}	150	°C	
Storage Temperature Range		$\mathrm{T_{stg}}$	-55~150	$^{\circ}\mathrm{C}$	

Unit in mm



Weight: 0.36 g

The information contained herein is subject to change without notice.

1999-06-16 1/4

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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARAC	TERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current		I_{CBO}	$V_{CB} = -50 \text{ V}, I_{E} = 0$		_	-1.0	μ A
Emitter Cut-of	ff Current	I_{EBO}	$V_{EB} = -5 V, I_{C} = 0$	_	_	-1.0	μ A
Collector-Emit Breakdown Vo		V _(BR) CEO	$I_{C} = -10 \text{ mA}, I_{B} = 0$	-50	_	_	V
DC Current Gain		hFE (1) (Note)	$V_{CE} = -2 V, I_{C} = -0.5 A$	70	_	240	
		hFE (2)	$V_{CE} = -2 V, I_{B} = -1.5 A$	40	_	_	
Collector-Emitter Saturation Voltage		V _{CE} (sat)	$I_{\rm C} = -1 A, I_{\rm B} = -0.05 A$	1	_	-0.5	V
Base-Emitter Saturation Voltage		V _{BE} (sat)	$I_{\rm C} = -1 A, I_{\rm B} = -0.05 A$	_	_	-1.2	V
Transition Frequency		$ m f_{T}$	$V_{CE} = -2 V, I_{C} = -0.5 A$		100	_	MHz
Collector Output Capacitance		Cob	$V_{CB} = -10 \text{ V}, I_{E} = 0,$ f = 1 MHz		40	_	pF
Switching	Turn-on Time	t _{on}	$\begin{array}{c c} & \text{INPUT} & \underline{\text{IB2}} & \text{OUTPUT} \\ \hline 20 & \mu_{\text{S}} & \hline \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ & & & \\ \end{array}$	l	0.1	_	
	Storage Time	t _{stg}	IB1 I		1.0	_	μs
	Fall Time	t_f	$ \begin{array}{lll} -I_{B1} = I_{B2} = 0.05 A & V_{CC} = -30 V \\ DUTY \; CYCLE \leq 1\% & \end{array} $		0.1	_	

Note : $h_{FE(1)}$ Classification O : $70\sim140$, Y : $120\sim240$

